


<b>Search Notes</b>  	<b>Application/Control No.</b>  10031723	<b>Applicant(s)/Patent Under Reexamination</b>  MAXWELL ET AL.
	<b>Examiner</b>  Kaplan, Hal I	<b>Art Unit</b>  2836

SEARCHED			
Class	Subclass	Date	Examiner
307	116	2/9/07	HK

SEARCH NOTES		
Search Notes	Date	Examiner
331/65 (consulted David Mis)	2/21/07	HK
Tech search (consulted Robert DeBeradinis)	2/21/07	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EP,JPO,DERWENT,IBM_TDB) - See Search History Printout	2/9/07	HK
EAST (US-PGPUB,USPAT,USOCR,FPRS,EP,JPO,DERWENT,IBM_TDB) - See Search History Printout	2/21/07	HK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
Interference Search History Printout		2/9/07	HK